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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10090612	FILING DATE 03/06/2002	CLASS 257	SUBCLASS 700MS	GAU 2821	EXAMINER Ho
**APPLICANTS: Aoki Yoshio; Mimino Yutaka; Baba Osamu; Gotoh Muneharu; 343					
**CONTINUING DATA VERIFIED: T.H. None					
** FOREIGN APPLICATIONS VERIFIED: JAPAN 2001-99961 03/30/2001 T.H.					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>			
Foreign priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no		ATTORNEY DOCKET NO			
35 USC 119 conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no		020131			
Verified and Acknowledged Examiners's initials T.H.					
TITLE : High-frequency semiconductor device					

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOT
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DRAWINGS			CLAIMS ALLOWED	
Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
(Assistant Examiner) (Date)			NOTICE OF ALLOWANCE MAILED	
			ISSUE FEE	
			Amount Due	Date Paid
(Primary Examiner) (Date)			ISSUE BATCH NUMBER	
(Legal Instruments Examiner) (Date)				

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